



Notice of References Cited

Application/Control No.

10/664,631

Applicant(s)/Patent Under
Reexamination
ERAN ET AL.

Examiner

TUAN H. NGUYEN

Art Unit

2618

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0203740	10-2004	Won et al.	455/426.1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
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FOREIGN PATENT DOCUMENTS

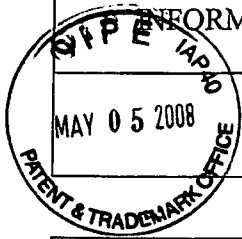
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

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FORM PTO-1449 (Colb)	ATTY DOCKET NO. 91366	SERIAL NUMBER 10764963 10/764,963
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANTS' INFORMATION STATEMENT	APPLICANT Eran SHPAK	EXAMINER (N/A) C.M. Brandt
	FILING DATE January 26, 2004	GROUP ART UNIT 3679 2617



GAU: 2617

U.S. PATENT DOCUMENTS

Examiner's Initials		DOCUMENT NO.	DATE	NAME	CLASS	SUB	FILING DATE
	AA	2004/0203740	10-2004	Won, et al.			
	AB						
	AC						
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EXAMINER: /Christopher Brandt/	DATE CONSIDERED: 10/09/2008
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